LIST OF PRIOR ART CITED BY APPLICANT (PTO-1449)				ATTY, DOCKET NO. P-0649		APPLN. SERIAL NO. New U.S. Application	
				APPLICANT(S) Hee-La PARK			
				CUSTOMER NO. 34610			
				FILING DATE April 15, 2004		GROUP art unit	
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EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME		CLASS	SUBCLASS	FILING DATE
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•	*PATENT APPLN. PUB. NO.	*PUB.	*APPLICANT		CLASS	SUBCLASS	
D·H	2002/0078228 A1	06/20/2002	Kuisma et al.		709	237	
D.H	2002/0126708 A1	09/12/2002	Skog et al.		370	522	<del></del>
D.H.	2002/0087549 A1	07/04/2002	Mostafa		707	10	
			U.S. PATENT APP	LICATIONS			
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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY		CLASS	CURCI ACC	Translation
D. H.	EP 1271970	01/02/2003	EUROPE (Abstract)		CLASS	SUBCLASS	Yes No
D.H.	JP 2002281550	09/27/2002	JAPAN (Abstract)		<del> </del>		
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	WO 0211398	02/07/2002	WIPO (Abstract)		<del> </del>		
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D.H.	WO 0133782	05/10/2001	WIPO (Abstrac		<del></del>		
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.